Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/084,638	BABICH, MICHAEL	
Examiner	Art Unit	
Ners M. Bassay	1614	

SEARCHED				
Class	Subdass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
updated previous search	12/27/2005	PN	
updated previous search	6/29/2006	NR	
updated previous scarch	12/21/2001	NHIL	
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